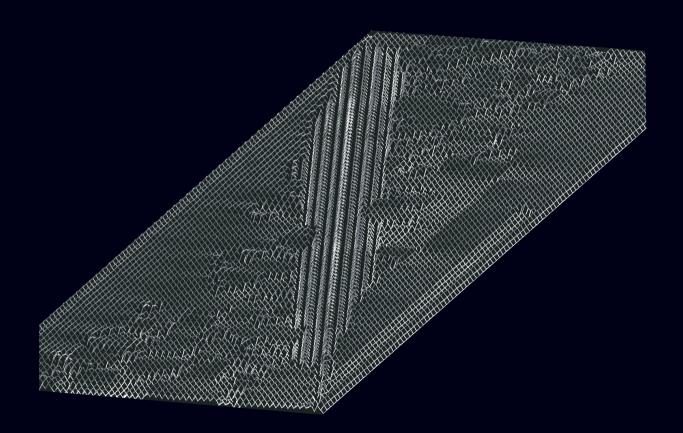
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National Institute of Standards and Technology
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Cover: The cover illustration shows a three-dimensional simulation of twinned-Martensite. For more information on a computational method for approximating twinned-Martensite, see the article "Simulation of an Austenite-twinned-Martensite Interface," by A. J. Kearsley and L. A. Melara, Jr. on p. 413. Cover figure arranged by C. Carey.	d for approximating twinne ce," by A. J. Kearsley and I	d-Martensite, see the article "	



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